ED-26765-000

SHT I.I

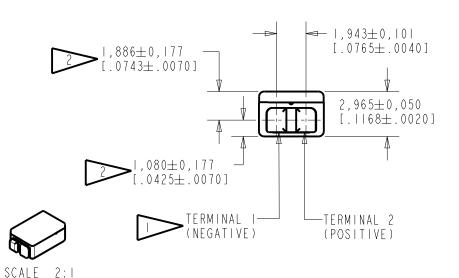
NOTE:

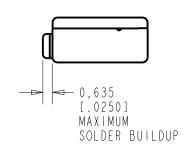
6,30±0,051 [.2480±.0020]

- 4,293±0,050 [.1690±.0020] A POSITIVE GOING VOLTAGE AT TERMINAL 2, RELATIVE TO TERMINAL I, CAUSES A DECREASE IN PRESSURE AT THE SOUND OUTLET.



LOCATED FROM TWO SURFACES FOR CUSTOMER CONVENIENCE. ONLY APPLICABLE FROM ONE SURFACE, NOT TO BE USED TOGETHER. HORIZONTAL LOCATION FOR TERMINAL CENTERED TO ± 0.178 [.0070].



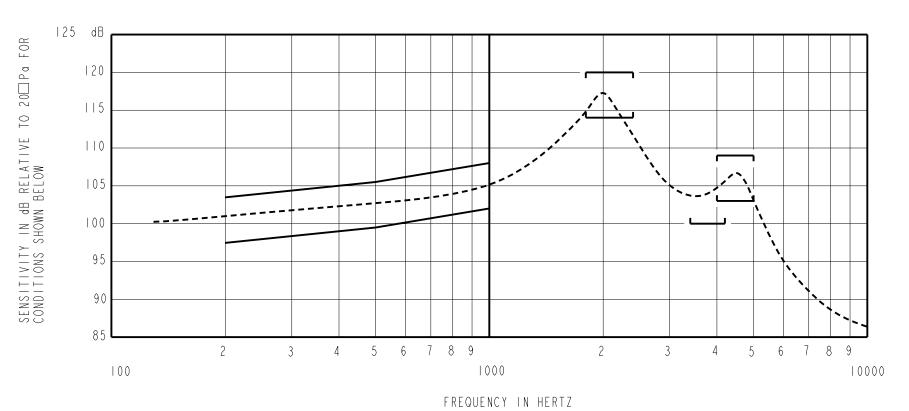


NOMINAL WEIGHT .31 GRAM

DIMENSIONS IN MILLIMETERS [INCHES]

KNOWLES ELECTRONICS ITASCA, ILLINOIS U.S.A.

Revision	C.O. #	Implementation Date	RELEASE LEVEL		REVISION
D	C10113123	2-6-12	Active		D
SCALE:	4:1				DATE 12-29-05
	DO NOT SCALE DRAWING				
TITLE:	RE	CEIVER	ED-26765-000	GJP APP. BY	1 - 3 - 0 6 DATE
	OUTL	INE DRAWING	SHT I.I	GJP	1 - 3 - 06



NOTES:

I. MEASUREMENTS MADE USING 10mm (.394") X 1mm (.039") ID TUBE CONNECTED TO A SIMULATED ANSI S3.7 TYPE HA-3 COUPLER. (IEC 60318-5).

2.		SENSITIVITY	
	FREQUENCY	MIN.	MAX.
	200	97.5 99.5	103.5
	1000 1800 - 2400 3400 - 4200	02.0 14.0 00.0	108.0
	4000-5000	103.0	109.0

- 3. RESPONSE, IMPEDANCE, AND DISTORTION MEASUREMENTS MADE USING THE ELECTRICAL TEST CONDITIONS SHOWN BELOW.
- 4. ELECTRICAL SOURCE IMPEDANCE MUST BE GREATER THAN 20 TIMES IKHZ IMPEDANCE FOR TEST CONDITIONS SHOWN BELOW.
- 5. INDIVIDUAL SPECIFICATIONS.

	PORT	IMPEDANCE OHMS ±15%		DCR @20°C	DISTORTION		ELECTRICAL TEST CONDITIONS	
	LOCATION	IKHz	500Hz	OHMS ±10%	MAX. %	FREQ Hz	AC mA RMS	DC mA
	12N	61	36	20	5	683	2.52	0.0

Revision	C.O. #	Implementation Date	Active		KEA1210N
D	C10113123	2-6-12			D
WHEN TEST LIMITS ARE USED TO ESTABLISH INCOMING INSPECTION ACCEPTANCE/REJECTION CRITERIA, CORRELATION OF TEST EQUIPMENT WITH KNOWLES IS ALSO REQUIRED FOR FILMINATION OF EQUIPMENT AND TEST METHOD VARIATION					DATE 2 - 29 - 05
ELIMINATION OF EGOTIMENT AND TEST METHOD VANTATION				CK. BY	DATE
TITLE:	RE	CEIVER	ED-26765-000	GJP APP. BY	1 - 3 - 0 6 DATE
	PEREARMAN	ACE SPECIFICATION	CHT 2 I	CID	1 2 00

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